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ACL Products	

74AC/ACT11286

9-bit odd/even parity generator/ checker with bus drive I/O port

FEATURES

- Generates either odd or even parity for nine data lines
- Word length easily expanded by cascading
- Direct bus connection for parity generation or for checking by using the parity I/O port
- Glitch-free bus during power up/down
- Output capability: ±24mA
- CMOS (AC) and TTL (ACT) voltage level inputs
- 50Ω incident wave switching
- Center-pin V_{CC} and ground configuration to minimize high-speed switching noise
- I_{CC} category: MSI

DESCRIPTION

The 74AC/ACT11286 high-performance CMOS devices combine very high speed and high output drive comparable to the most advanced TTL families.

The 74AC/ACT11286 9-bit parity generator or checker is commonly used to detect errors in high-speed data transmission or data retrieval systems. It fea-

(continued)

QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS T_{amb} = 25°C; GND = 0V; V_{CC} = 5.0V		TYPICAL AC	TYPICAL ACT	UNIT
t_{PLH}/ t_{PHL}	Propagation delay I_n to PARITY ERROR	C_L = 50pF		5.9	7.3	ns
C_{PD}	Power dissipation capacitance[1]	f = 1MHz; C_L = 50pF	Enabled	53	56	pF
			Disabled	46	50	
C_{IN}	Input capacitance	V_I = 0V or V_{CC}		3.5	3.5	pF
$C_{I/O}$	I/O capacitance	$V_{I/O}$ = 0V or V_{CC}; Disabled		8.5	8.5	pF
I_{LATCH}	Latch-up current	Per Jedec JC40.2 Standard 17		500	500	mA

Note:

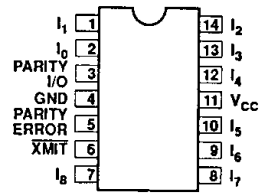
1. C_{PD} is used to determine the dynamic power dissipation (P_D in μW):
   $P_D = C_{PD} \times V_{CC}^2 \times f_I + \Sigma (C_L \times V_{CC}^2 \times f_O)$ where:
   f_I = input frequency in MHz, C_L = output load capacitance in pF,
   f_O = output frequency in MHz, V_{CC} = supply voltage in V,
   $\Sigma (C_L \times V_{CC}^2 \times f_O)$ = sum of outputs

ORDERING INFORMATION

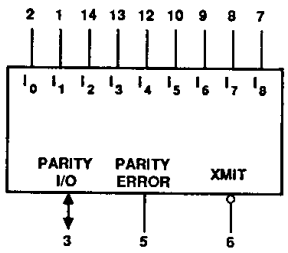
PACKAGES	TEMPERATURE RANGE	ORDER CODE
14-pin plastic DIP (300mil-wide)	-40°C to +85°C	74AC11286N 74ACT11286N
14-pin plastic SO (150mil-wide)	-40°C to +85°C	74AC11286D 74ACT11286D

PIN CONFIGURATION

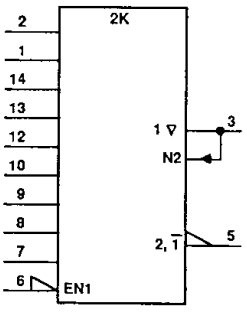
N and D Packages



LOGIC SYMBOL



LOGIC SYMBOL (IEEE/IEC)



9-bit odd/even parity generator/checker with bus drive I/O port

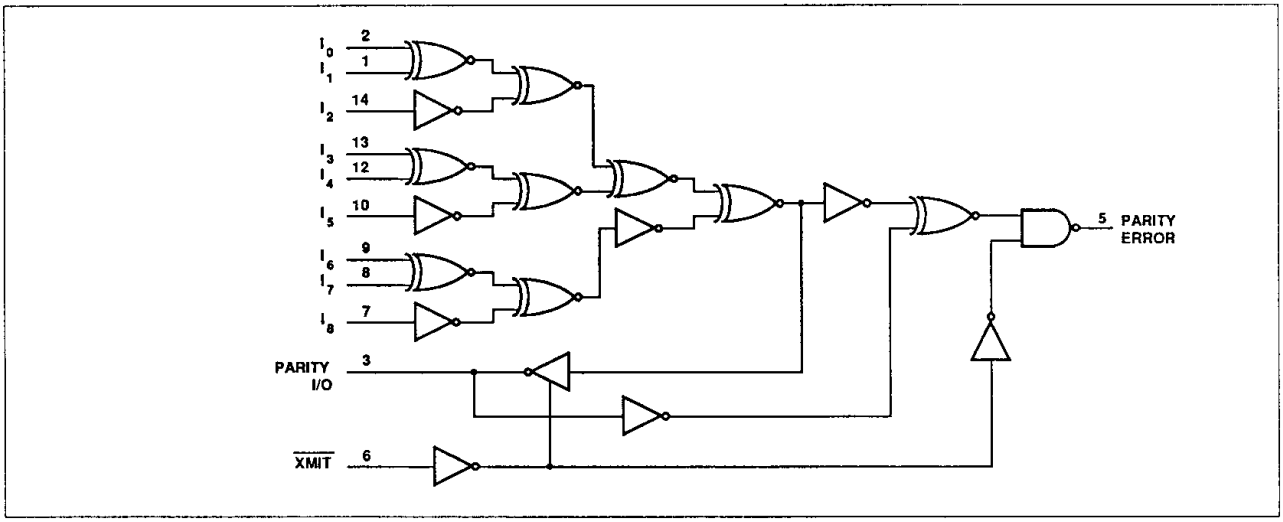
74AC/ACT11286

tures a local output for parity checking and a bus-driving parity I/O port for parity generation/checking.

The $\overline{XMIT}$ control input is implemented specifically for cascading for expanding word length. When $\overline{XMIT}$ is held Low the parity tree is disabled and the Parity Error output remains at a High logic level regardless of the other inputs (I_0 - I_8). When $\overline{XMIT}$ is High the parity tree is enabled. Parity Error indicates a parity error when either an even number of inputs are High and Parity I/O is forced to Low, or when an odd number of inputs are High and Parity I/O is forced High.

The I/O control circuitry is designed so that the I/O port will remain in the high-impedance state during power-up or power-down to prevent bus glitches.

LOGIC DIAGRAM



PIN DESCRIPTION

PIN NUMBER	SYMBOL	NAME AND FUNCTION
2, 1, 14, 13, 12, 10, 9, 8, 7	I_0 - I_8	Data inputs
3	PARITY I/O	Parity I/O
6	$\overline{XMIT}$	Transmit input (active Low)
5	PARITY ERROR	Parity error output
4	GND	Ground (0V)
11	V_{CC}	Positive supply voltage

FUNCTION TABLE

Number of High Data Inputs (I_0 - I_8)	$\overline{XMIT}$	PARITY I/O	PARITY ERROR
0, 2, 4, 6, 8	l	H	H
1, 3, 5, 7, 9	l	L	H
0, 2, 4, 6, 8	h	h	H
	h	l	L
1, 3, 5, 7, 9	h	h	L
	h	l	H

l = Low voltage level input
h = High voltage level input
H = High voltage level output
L = Low voltage level output

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	74AC11286			74ACT11286			UNIT
		Min	Nom	Max	Min	Nom	Max	
V_{CC}	DC supply voltage	3.0[1]	5.0	5.5	4.5	5.0	5.5	V
V_I	Input voltage	0		V_{CC}	0		V_{CC}	V
V_O	Output voltage	0		V_{CC}	0		V_{CC}	V
$\Delta t/\Delta v$	Input transition rise or fall rate	0		10	0		10	ns/V
T_{amb}	Operating free-air temperature range	-40		+85	-40		+85	°C

NOTE:
1. No electrical or switching characteristics are specified at V_{CC} < 3V. Operation between 2V and 3V is not recommended, but within that range, a device output will maintain a previously established logic state.

ABSOLUTE MAXIMUM RATINGS[1]

SYMBOL	PARAMETER	TEST CONDITIONS	RATING	UNIT
V_{CC}	DC supply voltage		-0.5 TO +7.0	V
I_{IK} or V_I	DC input diode current[2]	V_I < 0	-20	mA
		V_I > V_{CC}	20	
	DC input voltage		-0.5 to V_{CC} +0.5	V
I_{OK} or V_O	DC output diode current[2]	V_O < 0	-50	mA
		V_O > V_{CC}	50	
	DCoutput voltage		-0.5 to V_{CC} +0.5	V
I_O	DC output source or sink current per output pin	V_O = 0 to V_{CC}	±50	mA
I_{CC} or I_{GND}	DC V_{CC} current		±100	mA
	DC ground current		±100	
T_{STG}	Storage temperature		-65 to 150	°C
P_{TOT}	Power dissipation per package	Above 70°C; derate linearly by 8mW/K	500	mW
	Power dissipation per package Plastic surface mount (SO)	Above 70°C; derate linearly by 8mW/K	400	mW

NOTES:
1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
2. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

9-bit odd/even parity generator/checker with bus drive I/O port

74AC/ACT11286

DC ELECTRICAL CHARACTERISTICS

SYMBOL	PARAMETER	TEST CONDITIONS		V_{CC}	74AC11286				74ACT11286				UNIT
					T_{amb} = +25°C		T_{amb} = -40°C to +85°C		T_{amb} = +25°C		T_{amb} = -40°C to +85°C		
				V	Min	Max	Min	Max	Min	Max	Min	Max	
V_{IH}	High-level input voltage			3.0	2.10		2.10						V
				4.5	3.15		3.15		2.0		2.0		
				5.5	3.85		3.85		2.0		2.0		
V_{IL}	Low-level input voltage			3.0		0.90		0.90					V
				4.5		1.35		1.35		0.8		0.8	
				5.5		1.65		1.65		0.8		0.8	
V_{OH}	High-level output voltage	$V_I = V_{IL}$ or V_{IH}	I_{OH} = -50μA	3.0	2.9		2.9						V
				4.5	4.4		4.4		4.4		4.4		
				5.5	5.4		5.4		5.4		5.4		
			I_{OH} = -4mA	3.0	2.58		2.48						
			I_{OH} = -24mA	4.5	3.94		3.8		3.94		3.8		
				5.5	4.94		4.8		4.94		4.8		
			I_{OH} = -75mA[1]	5.5			3.85				3.85		
V_{OL}	Low-level output voltage	$V_I = V_{IL}$ or V_{IH}	I_{OL} = 50μA	3.0		0.1		0.1					V
				4.5		0.1		0.1		0.1		0.1	
				5.5		0.1		0.1		0.1		0.1	
			I_{OL} = 12mA	3.0		0.36		0.44					
			I_{OL} = 24mA	4.5		0.36		0.44		0.36		0.44	
				5.5		0.36		0.44		0.36		0.44	
			I_{OL} = 75mA[1]	5.5				1.65				1.65	
I_I	Input leakage current	$V_I = V_{CC}$ or GND		5.5		±0.1		±1.0		±0.1		±1.0	μA
I_{OZ}	3-State output off-state current	$V_I = V_{IL}$ or V_{IH}, $V_O = V_{CC}$ or GND		5.5		±0.5		5.0		±0.5		5.0	μA
I_{CC}	Quiescent supply current	$V_I = V_{CC}$ or GND, I_O = 0mA		5.5		8.0		80		8.0		80	μA
ΔI_{CC}	Supply current, TTL inputs High[2]	One input at 3.4V, other inputs at V_{CC} or GND		5.5						0.9		1.0	mA

NOTES:
1. Not more than one output should be tested at a time, and the duration of the test should not exceed 10ms.
2. This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0V or V_{CC}.

AC ELECTRICAL CHARACTERISTICS AT 3.3V ±0.3V

SYMBOL	PARAMETER	WAVEFORM	74AC11286					UNIT
			T_{amb} = +25°C			T_{amb} = -40°C to +85°C		
			Min	Typ	Max	Min	Max	
t_{PLH} t_{PHL}	Propagation delay I_n to PARITY I/O	1	2.6 3.8	10.0 11.6	11.7 14.5	2.6 3.8	13.1 16.1	ns
t_{PLH} t_{PHL}	Propagation delay I_n to PARITY ERROR	1	3.0 4.0	8.5 10.9	13.1 16.0	3.0 4.0	14.7 17.8	ns
t_{PLH} t_{PHL}	Propagation delay PARITY I/O to PARITY ERROR	1	2.2 3.4	5.9 7.9	7.6 10.2	2.2 3.4	8.4 11.1	ns
t_{PZH} t_{PHZ}	Propagation delay $\overline{XMIT}$ to PARITY I/O	2	1.8 3.2	4.9 5.4	6.4 6.6	1.8 3.2	7.0 7.0	ns
t_{PZL} t_{PLZ}	Propagation delay $\overline{XMIT}$ to PARITY I/O	2	3.5 3.2	9.7 5.4	12.8 6.7	3.5 3.2	13.6 7.2	ns

AC ELECTRICAL CHARACTERISTICS AT 5.0V ±0.5V

SYMBOL	PARAMETER	WAVEFORM	74AC11286					UNIT
			T_{amb} = +25°C			T_{amb} = -40°C to +85°C		
			Min	Typ	Max	Min	Max	
t_{PLH} t_{PHL}	Propagation delay I_n to PARITY I/O	1	2.0 3.1	5.5 6.9	8.0 9.1	2.0 3.1	9.0 10.7	ns
t_{PLH} t_{PHL}	Propagation delay I_n to PARITY ERROR	1	2.5 3.3	5.2 6.5	8.9 10.7	2.5 3.3	10.0 12.0	ns
t_{PLH} t_{PHL}	Propagation delay PARITY I/O to PARITY ERROR	1	1.9 2.9	3.9 5.0	5.6 7.2	1.9 2.9	6.2 7.9	ns
t_{PZH} t_{PHZ}	Propagation delay $\overline{XMIT}$ to PARITY I/O	2	1.4 3.1	3.3 4.8	4.9 6.1	1.4 3.1	5.3 6.5	ns
t_{PZL} t_{PLZ}	Propagation delay $\overline{XMIT}$ to PARITY I/O	2	3.0 3.0	5.4 4.6	8.3 6.0	3.0 3.0	8.9 6.3	ns

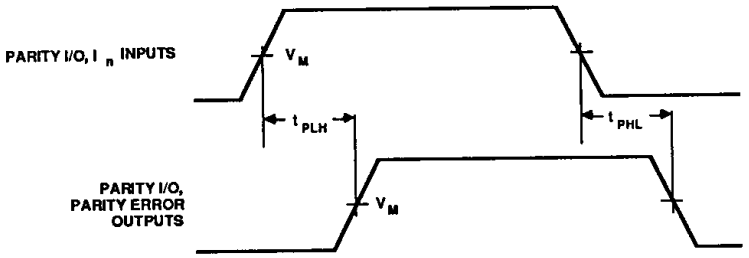
AC ELECTRICAL CHARACTERISTICS AT 5.0V ±0.5V

SYMBOL	PARAMETER	WAVEFORM	74ACT11286					UNIT
			T_{amb} = +25°C			T_{amb} = -40°C to +85°C		
			Min	Typ	Max	Min	Max	
t_{PLH} t_{PHL}	Propagation delay I_n to PARITY I/O	1	2.7 3.6	6.1 7.3	8.0 10.8	2.7 3.6	10.4 12.0	ns
t_{PLH} t_{PHL}	Propagation delay I_n to PARITY ERROR	1	3.0 3.9	6.9 7.7	9.7 11.4	3.0 3.9	11.3 12.9	ns
t_{PLH} t_{PHL}	Propagation delay PARITY I/O to PARITY ERROR	1	2.2 3.1	4.6 5.6	6.8 8.3	2.2 3.1	7.7 9.1	ns
t_{PZH} t_{PHZ}	Propagation delay $\overline{XMIT}$ to PARITY I/O	2	1.8 4.7	4.2 6.5	6.3 7.9	1.8 4.7	7.3 8.5	ns
t_{PZL} t_{PLZ}	Propagation delay $\overline{XMIT}$ to PARITY I/O	2	3.0 4.1	6.3 6.0	9.4 7.3	3.0 4.1	11.4 7.8	ns

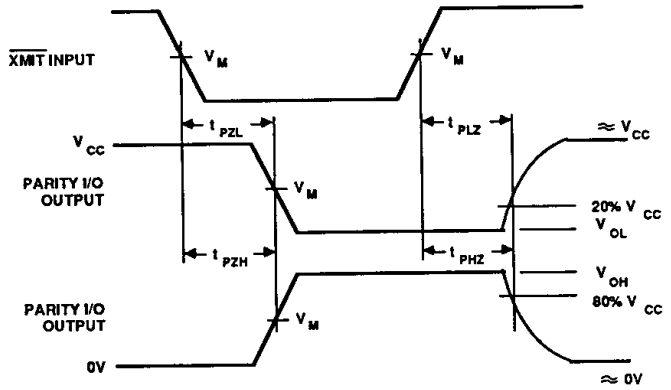
9-bit odd/even parity generator/checker with bus drive I/O port

74AC/ACT11286

AC WAVEFORMS



Waveform 1. Waveforms Showing the Inputs (I_n, PARITY I/O) to Outputs (PARITY ERROR, PARITY I/O) Propagation Delays



Waveform 2. Waveforms Showing the 3-State Output Enable and Disable Times

WAVEFORM CONDITIONS

	INPUTS	OUTPUTS
AC	V_{IN} = GND to V_{CC}, V_M = 50% V_{CC}	V_{OUT} = V_{OL} to V_{OH}
ACT	V_{IN} = GND to 3.0V, V_M = 1.5V	V_M = 50% V_{CC}

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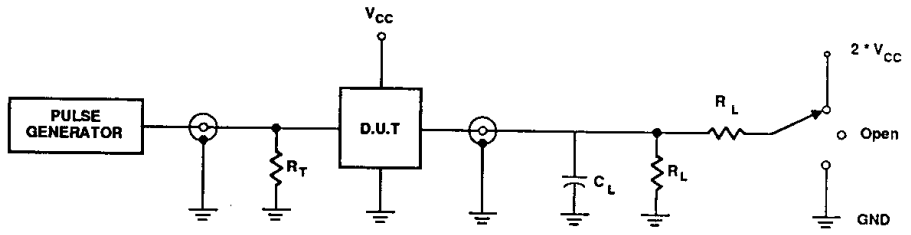
74AC/ACT11286

TEST CIRCUIT



Test Circuit

TEST	S1
t_{PLH}/t_{PHL}	Open
t_{PLZ}/t_{PZL}	$2*V_{CC}$
t_{PHZ}/t_{PZH}	GND

SWITCH POSITION

DEFINITIONS

C_L = Load capacitance, 50pF; includes jig and probe capacitance

R_L = Load resistor, 500Ω

R_T = Termination resistance should be equal to Z_{OUT} of pulse generators

Input pulses: PRR ≤ 10MHz

$t_r = t_f$ = 3ns